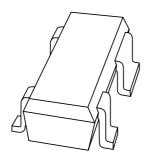
## **DISCRETE SEMICONDUCTORS**

## DATA SHEET



# **BFU540**NPN SiGe wideband transistor

Product specification Supersedes data of 2002 Jan 28 2003 Jun 12





## **NPN SiGe wideband transistor**

**BFU540** 

#### **FEATURES**

- · Very high power gain
- · Very low noise figure
- · High transition frequency
- · Emitter is thermal lead
- · Low feedback capacitance
- 45 GHz SiGe process.

#### **APPLICATIONS**

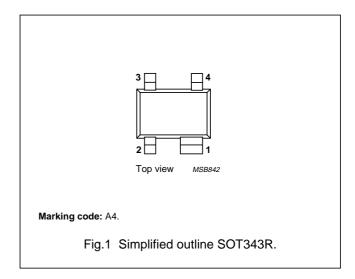
- · RF front end
- Wideband applications, e.g. analog and digital cellular telephones, cordless telephones (PHS, DECT, etc.)
- · Radar detectors
- Pagers
- Satellite television tuners (SATV)
- · High frequency oscillators.

#### **DESCRIPTION**

NPN SiGe wideband transistor for low voltage applications in a plastic, 4-pin dual-emitter SOT343R package.

#### **PINNING**

PIN	DESCRIPTION	
1	emitter	
2	base	
3	emitter	
4	collector	



#### **QUICK REFERENCE DATA**

SYMBOL	PARAMETER	CONDITIONS		TYP.	MAX.	UNIT
V <sub>CBO</sub>	collector-base voltage	open emitter	_	_	9	V
V <sub>CEO</sub>	collector-emitter voltage	open base	-	_	2.3	٧
Ic	collector current (DC)	-		40	50	mA
P <sub>tot</sub>	total power dissipation	$T_s \le 98  ^{\circ}C$		_	115	mW
h <sub>FE</sub>	DC current gain	$I_C = 40 \text{ mA}; V_{CE} = 2 \text{ V}; T_j = 25 \text{ °C}$		140	210	
G <sub>max</sub>	maximum power gain	$I_C = 40$ mA; $V_{CE} = 2$ V; $f = 2$ GHz; $T_{amb} = 25$ °C	_	20	_	dB
NF	noise figure	$I_C = 2 \text{ mA}$ ; $V_{CE} = 2 \text{ V}$ ; $f = 2 \text{ GHz}$ ; $\Gamma_S = \Gamma_{opt}$	_	0.9	_	dB

#### **CAUTION**

This product is supplied in anti-static packing to prevent damage caused by electrostatic discharge during transport and handling. For further information, refer to Philips specs.: SNW-EQ-608, SNW-FQ-302A and SNW-FQ-302B.

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#### **LIMITING VALUES**

In accordance with the Absolute Maximum Rating System (IEC 60134).

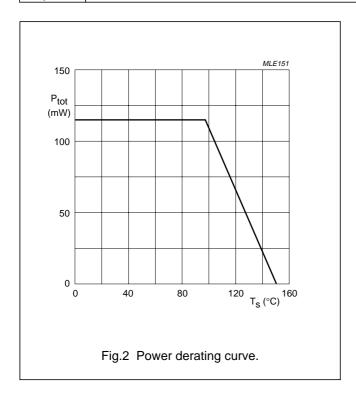
SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V <sub>CBO</sub>	collector-base voltage	open emitter	_	9	V
V <sub>CEO</sub>	collector-emitter voltage	open base	_	2.3	V
$V_{EBO}$	emitter-base voltage	open collector	_	2.5	V
I <sub>C</sub>	collector current (DC)		_	50	mA
P <sub>tot</sub>	total power dissipation	$T_s \le 98$ °C; note 1; see Fig.2	_	115	mW
T <sub>stg</sub>	storage temperature		-65	+150	°C
Tj	operating junction temperature		_	150	°C

#### Note

1.  $T_s$  is the temperature at the soldering point of the emitter pins.

#### THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	VALUE	UNIT
R <sub>th j-s</sub>	thermal resistance from junction to soldering point	450	K/W



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#### **CHARACTERISTICS**

 $T_j$  = 25 °C; unless otherwise specified.

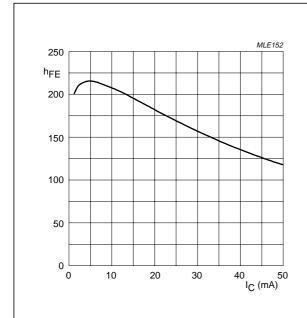
SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
V <sub>(BR)CBO</sub>	collector-base breakdown voltage	$I_C = 2.5 \mu\text{A}; I_E = 0$	9	_	_	٧
V <sub>(BR)CEO</sub>	collector-emitter breakdown voltage	I <sub>C</sub> = 1 mA; I <sub>B</sub> = 0	2.3	_	_	V
V <sub>(BR)EBO</sub>	emitter-base breakdown voltage	$I_E = 2.5 \mu\text{A};  I_C = 0$	2.5	_	_	V
I <sub>CBO</sub>	collector-base leakage current	I <sub>E</sub> = 0; V <sub>CB</sub> = 4.5 V	_	_	15	nA
h <sub>FE</sub>	DC current gain	I <sub>C</sub> = 40 mA; V <sub>CE</sub> = 2 V	70	140	210	
C <sub>c</sub>	collector capacitance	$I_E = i_e = 0$ ; $V_{CB} = 2$ V; $f = 1$ MHz	_	520	_	fF
C <sub>re</sub>	feedback capacitance	I <sub>C</sub> = 0; V <sub>CB</sub> = 2 V; f = 1 MHz	_	105	_	fF
G <sub>max</sub>	maximum power gain; note 1	$I_C = 40 \text{ mA}; V_{CE} = 2 \text{ V}; f = 2 \text{ GHz}; $ $T_{amb} = 25 ^{\circ}\text{C}$	_	20	_	dB
NF	noise figure	$I_C = 2 \text{ mA}$ ; $V_{CE} = 2 \text{ V}$ ; $f = 2 \text{ GHz}$ ; $\Gamma_S = \Gamma_{opt}$	_	0.9	_	dB
P <sub>L1</sub>	output power at 1 dB gain compression	$I_C = 20 \text{ mA}; V_{CE} = 2 \text{ V}; f = 2 \text{ GHz}; $ $Z_S = Z_{S \text{ opt}}; Z_L = Z_{L \text{ opt}}; \text{ note } 2$	_	11	_	dBm
ITO	third order intercept point	$I_C = 40 \text{ mA}; V_{CE} = 2 \text{ V}; f = 2 \text{ GHz}; $ $Z_S = Z_{S \text{ opt}}; Z_L = Z_{L \text{ opt}}; \text{ note } 2$	_	21	_	dBm

#### **Notes**

- 1.  $G_{max}$  is the maximum power gain, if K > 1. If K < 1 then  $G_{max} = MSG$ .
- 2.  $Z_S$  and  $Z_L$  are optimized for gain.

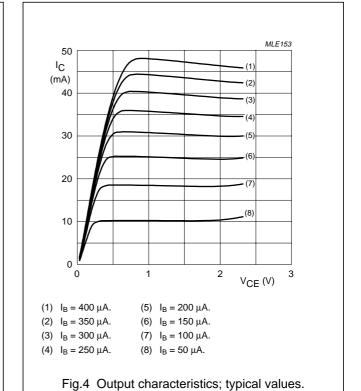
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 $V_{CE} = 2 \text{ V}; T_j = 25 \,^{\circ}\text{C}.$ 

Fig.3 DC current gain as a function of collector current; typical values.



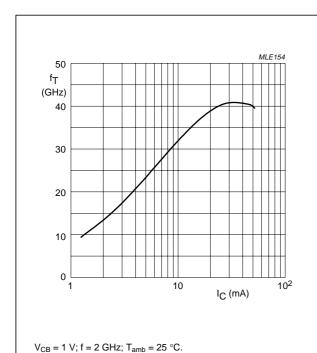
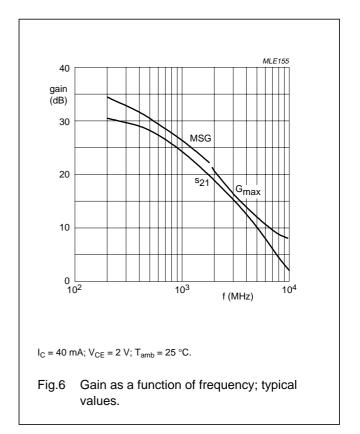


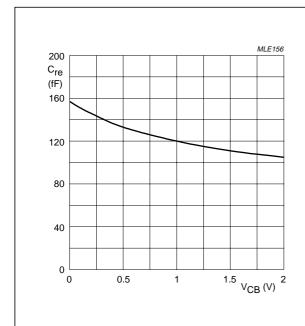
Fig.5 Transition frequency as a function of collector current; typical values.



Product specification Philips Semiconductors

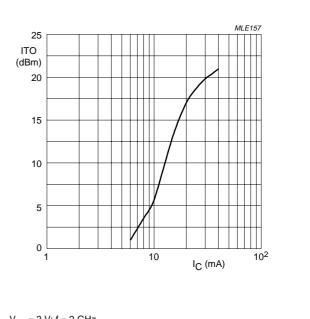
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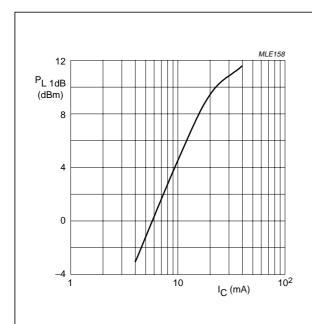
 $I_C$  = 0; f = 1 MHz;  $T_{amb}$  = 25 °C.

Fig.7 Feedback capacitance as a function of collector-base voltage; typical values.



V<sub>CE</sub> = 2 V; f = 2 GHz.

Fig.8 Third order intercept point as a function of collector current.



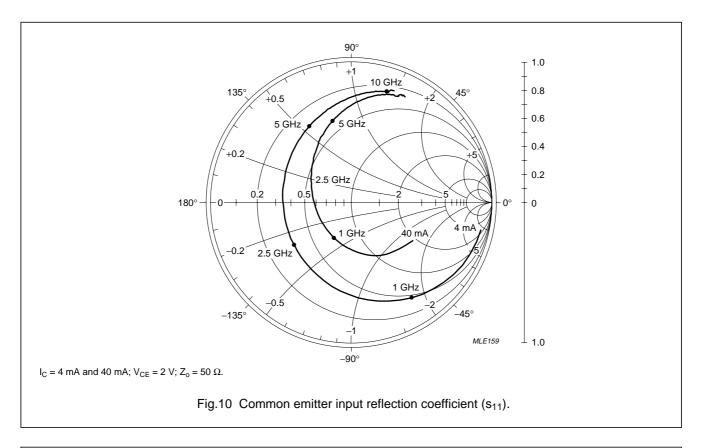
 $V_{CE}$  = 2 V; f = 2 GHz; source and load tuned for optimum gain.

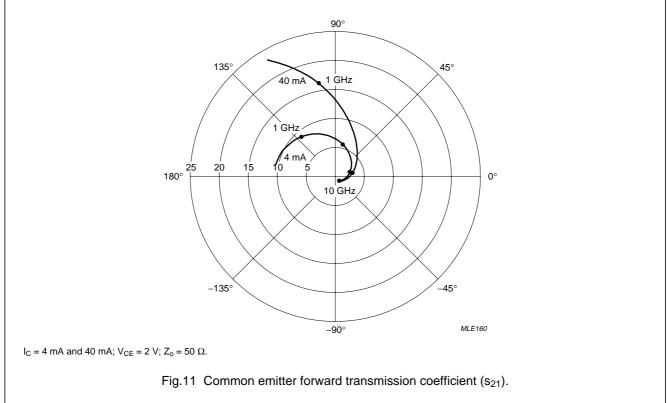
Fig.9 Output power at 1 dB gain compression as a function of collector current.

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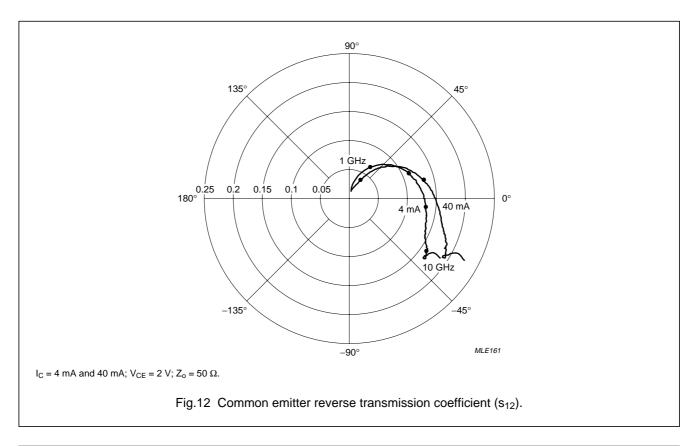
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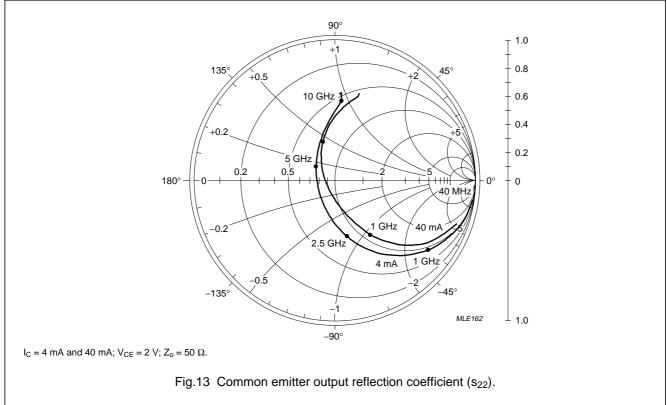




## NPN SiGe wideband transistor

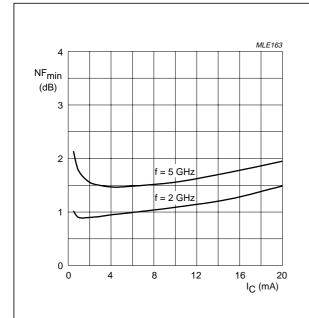
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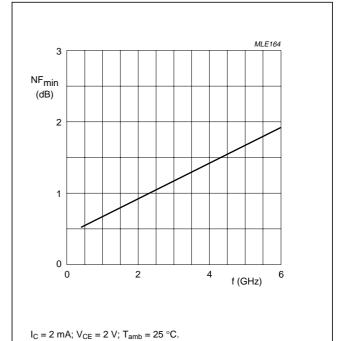
## NPN SiGe wideband transistor

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 $V_{CE}$  = 2 V;  $T_{amb}$  = 25  $^{\circ}C.$ 

Fig.14 Minimum noise figure as a function of collector current.



1C = 2 1117, VCE = 2 V, Tamb = 20 0.

Fig.15 Minimum noise figure as a function of frequency.

Noise data:  $V_{CE}$  = 2 V;  $I_{C}$  = 4 mA;  $T_{amb}$  = 25 °C; typical values

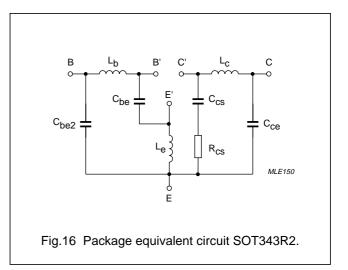
f (GHz)	F <sub>min</sub>	$\Gamma_{opt}$		r <sub>n</sub>
	(dB)	(mag)	(deg)	<b>(</b> Ω <b>)</b>
2	1.0	0.39	55.9	0.20
3	1.2	0.23	86.8	0.15
4	1.4	0.11	142.5	0.13
5	1.6	0.14	-121.0	0.16
6	1.7	0.28	-74.2	0.27
7	1.9	0.41	-52.1	0.43
8	2.1	0.47	-32.6	0.66
9	2.3	0.54	-14.1	0.91
10	2.6	0.62	3.7	1.22
11	2.8	0.63	22.7	1.44
12	3.0	0.61	36.8	1.65

## NPN SiGe wideband transistor

## BFU540

## SPICE parameters for the BFU540 die

SEQUENCE No.	PARAMETER	VALUE	UNIT
1	IS	1.5	аА
2	BF	271.5	_
3	NF	1.061	_
4	VAF	25	V
5	IKF	68	mA
6	ISE	1060	fA
7	NE	2.9	_
8	BR	50	_
9	NR	1.01	_
10	VAR	1	MV
11	IKR	6.4	mA
12	ISC	1.2	fA
13	NC	1.21	_
14	RB	8.75	Ω
15 <sup>(1)</sup>	IRB	_	_
16	RBM	5	Ω
17	RE	0.9	mΩ
18	RC	9.25	Ω
19	XTB	-2.2	_
20	EG	1.014	eV
21	XTI	3	_
22	CJE	222	fF
23	VJE	918	mV
24	MJE	0.27	_
25	TF	2.1	ps
26	XTF	10	_
27	VTF	1.5	V
28	ITF	0.92	Α
29	PTF	30	deg
30	CJC	147	fF
31	VJC	587	mV
32	MJC	0.246	_
33	XCJC	0.44	_
34	TR	20	ps
35	CJS	51	fF
36	VJS	441	mV
37	MJS	0.313	_
38	FC	0.7	_



## List of components (see Fig.16)

DESIGNATION	VALUE	UNIT
L <sub>b</sub>	1.18	nH
L <sub>c</sub>	1.04	nH
L <sub>e</sub>	0.32	nH
C <sub>be1</sub>	146	fF
C <sub>be2</sub>	55	fF
C <sub>ce</sub>	56	fF
C <sub>cs</sub>	100	fF
R <sub>cs</sub>	170	Ω

#### Note

1. Not used.

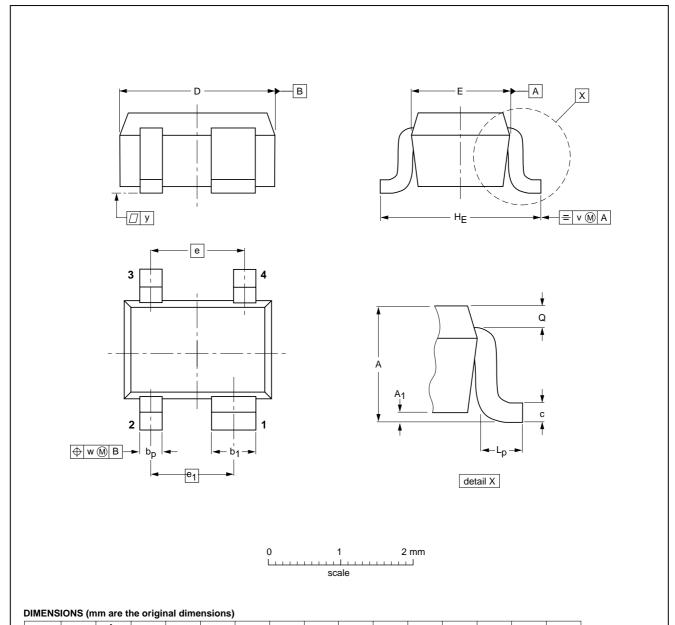
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#### **PACKAGE OUTLINE**

Plastic surface mounted package; reverse pinning; 4 leads

SOT343R



OUTLINE	OUTLINE		REFERENCES		EUROPEAN	ISSUE DATE
VERSION	IEC	JEDEC	EIAJ		PROJECTION	ISSUE DATE
SOT343R						97-05-21

1.3

 $H_{\mathsf{E}}$ 

e<sub>1</sub>

1.15

Lp

0.45

0.2

0.2

У

0.1

Ε

1.15

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bp

max

0.1

0.8

 $b_1$ 

0.5

0.25

UNIT

mm

## NPN SiGe wideband transistor

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#### **DATA SHEET STATUS**

LEVEL	DATA SHEET STATUS <sup>(1)</sup>	PRODUCT STATUS(2)(3)	DEFINITION
I	Objective data	Development	This data sheet contains data from the objective specification for product development. Philips Semiconductors reserves the right to change the specification in any manner without notice.
II	Preliminary data	Qualification	This data sheet contains data from the preliminary specification. Supplementary data will be published at a later date. Philips Semiconductors reserves the right to change the specification without notice, in order to improve the design and supply the best possible product.
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- 3. For data sheets describing multiple type numbers, the highest-level product status determines the data sheet status.

#### **DEFINITIONS**

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Limiting values definition — Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 60134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

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**NOTES** 

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#### **Contact information**

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